



Room-temperature dephasing in InAs/GaAs quantum dots

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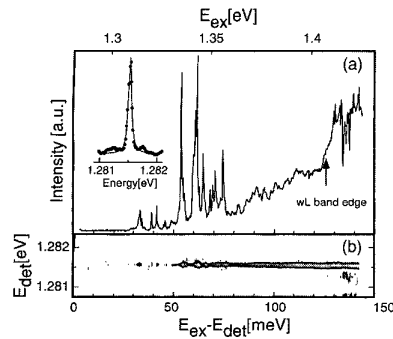
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QTuC1 Fig. 1. (a) Typical PLE spectrum of a PL feature as shown in the inset. The PL was excited by a Ti:sapphire laser with a frequency resolution of ~ 10 GHz and an excitation density of ~ 10 W/cm². The horizontal bottom axis represents the relaxation energy (E_{rel}), which corresponds to the difference between excitation and detection energies ($E_{exc} - E_{det}$). Solid line in the inset indicates a Lorentzian fit to the PL data with $E_{ex} = 1.43$ eV. The luminescence linewidth is estimated to be ~ 70 μ eV. (b) PL intensities corresponding to the data in (a) are plotted as a function of detection and excitation energy.

When the relaxation energy matches an available phonon energy, the emitted photons fulfil the resonance condition by the emission of a LO phonon. Therefore, the observed PLE resonances are attributed to resonant Raman features.

These results provide new insights into the relaxation process in SAQDs as follows: the carriers can relax within continuum states, and make transitions to the excitonic ground state by resonant phonon scattering before PL emission, thus allowing for the intense PL peak observed for SAQDs.

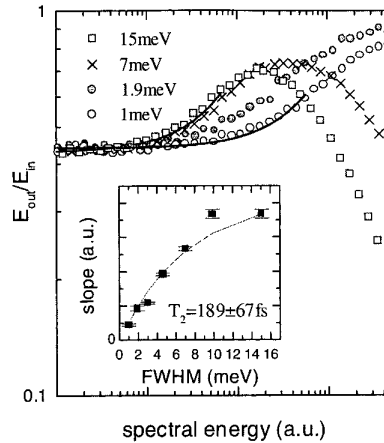
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QTuC2 8:15 am Room-temperature dephasing in InAs/GaAs quantum dots

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Semiconductor quantum dots (QDs) are receiving increasing attention for fundamental studies on zero-dimensional confinement and for device applications. Quantum-dot lasers are expected to show superior performances, like high material gain, low and temperature-independent threshold current and chirp-free operation,¹ due to the delta-like density of states (DOS).

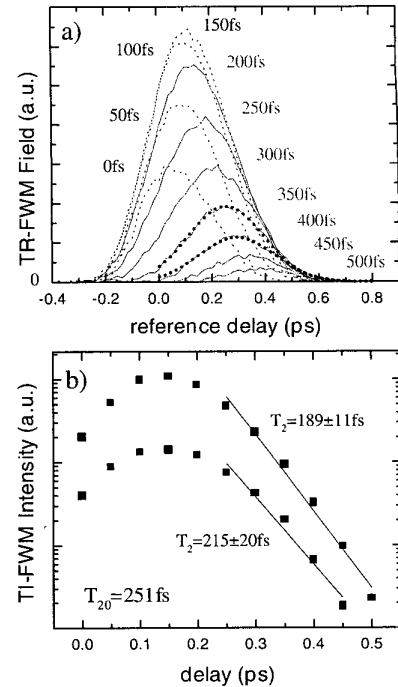


QTuC2 Fig. 1. QD transmission (in logarithmic scale) as a function of the input spectral energy for different spectral widths. The wavelength of the injected pulses was centered at 1.08 μ m, corresponding to the ground state transition of the dots. Solid lines are fits to the data. In the inset, the slopes of the initial absorption bleaching and a fit according to our model are shown.

In this work we have measured the dephasing time at room temperature of InAs QDs embedded in a waveguide to estimate the lower limit for the energy-broadening of the DOS given by the homogeneous linewidth. The sample consists of 3 stacked layers of InAs/InGaAs/GaAs quantum dots in the center of 120 nm GaAs embedded between two $Al_{0.7}Ga_{0.3}As$ cladding layers,² in a ridge structure 8 μ m wide and 400 μ m long, with tilted facets. In Fig. 1 the responses of the device under injection of Fourier-limited optical pulses of different spectral widths are shown. The energy of the pulse at the output of the waveguide is measured by a Ge-detector with lock-in technique. A bleaching of the absorption with increasing input intensity is clearly observed. Additionally, short pulses experience increasing absorption with input intensity due to two-photon absorption.

For a constant input spectral energy E_{ω} (energy per unit frequency) different bleaching occurs for different pulse-widths. This is simulated (solid lines in figure) by modeling the spectral hole-burning of the absorption coefficient induced by a pulse with a spectral width larger (open square) or smaller (open circle) than the homogeneous broadening of the dots. The bleaching shows a linear decrease of the absorption versus E_{ω} with a slope that depends on pulse-width and dephasing time T_2 . In the inset, the slopes obtained from the initial bleaching are shown, with a fit according to our model, giving $T_2 = 189 \pm 67$ fs.

Another technique for measuring dephasing is four-wave mixing (FWM).³ FWM in thin films with spatial selection of the non-linear signal has been widely reported. However, FWM on In(Ga)As QDs has not yet been reported due to the weak signal from the small interaction volume and the large inhomogeneous broadening. We have used the heterodyne technique discussed in Ref. 4 to perform FWM in the waveguide geometry, with the advantage of using the entire length of the



QTuC2 Fig. 2. (a) Time-resolved FWM electric field for different delay times of the two exciting beams. The photon-echo nature of the FWM is evident from the shift of the signal at long delay. Bold dotted lines are fits of the data. (b) Time-integrated FWM intensity (electric field square) in the case of (a) (upper curve) and for half the excitation intensity (lower curve). Solid lines are fits of the data. The deduced dephasing times are indicated; T_{20} is the extrapolated zero-density value.

device as interaction length. Figure 2(a) shows the amplitude of the time-resolved FWM electric field, by scanning over the delay of the reference beam, at different delay times τ of the exciting beams. Excitation and reference pulses had 200 fs intensity-autocorrelation width. The photon-echo nature of the FWM is seen by the time-shift of the signal. A fit of the signal for $\tau = 350, 400$ fs is performed by using the formula:³ $E(t) = E_0 e^{-t/T_2} e^{-\sigma^2(t-\tau)^2/4}$ where σ is 1.4 times the standard deviation of a Gaussian distribution. $T_2 = 183 \pm 5$ fs is obtained. The integrated area of the FWM intensity is shown in Fig. 2(b) for the field reported in Fig. 2(a) and for half the excitation intensity. A fit of the decay is shown³ and the corresponding values of T_2 are indicated, together with the zero-density extrapolated value. These values are in good agreement with the ones reported in Fig. 1 within error bars.

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